SECTION 2. FORMS PTO/SB/08A and 08B (formerly Form PTO-1449)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Nunan et al.

Attorney Docket:

2550/193

Serial No:

Not yet assigned

Art Group Unit:

Not yet assigned

Date Filed:

March 2, 2004

Examiner Name:

Not yet assigned

Invention:

Single Crystal Silicon Sensor With Additional Layer And Method Of Producing.

The Same

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

U.S. PATENT DOCUMENTS						
Examiner Initials	Reference Number	Document Number	Issue Date	Inventor	Class/Subclass	
13K5	AA	US 5,939,633	08/17/1999	Judy	73/514.32	
Ī	AB	US 6,505,511 B1	01/14/2003	Geen et al.	73/504.12	
	AC	US 5,569,621	10/29/1996	Yallup et al.	437/62	
	AD	US 6,465,280	10/15/2002	Martin et al.	438/125	

OTHER DOCUMENTS				
Examiner Initials	Reference Number	Author	Title of Article, Title of Journal, Volume Number, Page Numbers, Date	
BKS	AE	PC. Hsu et al.	A High Sensitivity Polysilicon Diaphragm Condensor Microphone, 1998 MEMS Conference, Pgs. 1-6, Jan. 25-29, 1998.	

Examiner Signature:

Date Considered:

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation *if not* in conformance and not considered. Include copy of this form with next communication to applicant.

02550/00193 298547.1

SECTION 2. FORMS PTO/SB/08A and 08B (formerly Form PTO-1449)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Nunan et al.

Attorney Docket:

2550/193

Serial No:

10/791,638

Art Group Unit:

2812

Date Filed:

March 2, 2004 6/2265

Examiner Name:

Not Yet Assigned

Invention:

SINGLE CRYSTAL SILICON SENSOR WITH ADDITIONAL LAYER AND

METHOD OF PRODUCING THE SAME

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

U.S. PATENT PUBLICATION DOCUMENTS					
Examiner Initials	Reference Number	Document Number	Publication Date	Inventor	Class/Subclass
RKS	AF	US 2002/127760	Sept. 12, 2002	Yeh et al.	438/50

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Reference Number	Country Code	Document Number	Publication Date	Patenteee or Applicant	Class/Subclass
BKS	AG	WO	99/00155	Jan. 7, 1999	Lebouitz et al.	A61M 5/32
BKS	АН	EP	1325885	July 9, 2003	Xerox Corporation	B81B 3/00
13/()	AI	WO	00/42231	July 20, 2000	Franke et al.	C23C .

	OTHER DOCUMENTS				
Examiner Initials	Reference Number	Author	Title of Article, Title of Journal, Volume Number, Page Numbers, Date		
15KS	AJ	Yi et al.	A Micro Active Probe Device Compatible with SOI-CMOS Technologies, Journal of Microelectromechanical Systems, IEEE Inc., Vol. 6, No. 3, September 1987, 7 pages.		
BKS	AK	Calamita, et al.	Hybrid integration of light emitters and detectors with SOI based Micro-Opto-Electro-Mechanical Systems (MOEMS), Proceedings of the SPIE, Silicon-Based and Hybrid Optoelectronics III, 23-24 Jan. 2001, Vol. 4293, 2001, pages 32-45.		
75/LS	AL	Franke et al.	Post-CMOS Integration of Germanium Microstructures, Micro Electro Mechnaical Systems, 1999, MEMS '99, Twelfth IEEE International Conference, 17-21 Jan., 1999, pages 630-637.		
75KS	AM	Authorized Officer Katrin Sommermeyer	Invitation to Pay Additional Fees/ Communication Relating to the Results of the Partial International Search, International Searching Authority, March 30, 2005, 6 pages.		

12/10/05

(Supplemental Information Disclosure Statement--page 4 of 7)